ESD224 Low Clamping 4-Channel ESD Protection Device for HDMI Interface

1 Features

- IEC 61000-4-2 Level 4 ESD Protection
  - ±12-kV Contact Discharge
  - ±15-kV Air Gap Discharge
- IEC 61000-4-4 EFT Protection
  - 80 A (5/50 ns)
- IEC 61000-4-5 Surge Protection
  - 2 A (8/20 µs)
- IO Capacitance:
  - 0.5 pF (Typical)
- HDMI 2.0 Compliant
- Ultra-Low Leakage Current: 0.1 nA (Typical)
- Ultra-Low ESD Clamping Voltage: 8 V at 16-A TLP (System Side)
- Supports High Speed Interfaces up to 6 Gbps
- Industrial Temperature Range: –40°C to +125°C
- Industry Standard DQA Package

2 Applications

- End Equipment
  - Set-Top Boxes
  - TV and Monitors
  - Laptops and Desktops
  - DVD, Blue-ray, Multimedia Players
- Interfaces
  - HDMI 2.0/1.4
  - Ethernet 10/100/1000 Mbps
  - USB 3.0

3 Description

The ESD224 is a bidirectional TVS ESD protection diode array for high speed applications such as USB 3.0 and HDMI 2.0. The ESD224 is rated to dissipate ESD strikes at the maximum level specified in the IEC 61000-4-2 international standard (Level 4). The ESD224 employs on-chip differentially matched series elements to enhance down-stream ESD clamping performance while maintaining the signal compliance for high speed interfaces. The ultra-low clamping performance and high differential bandwidth provided by the ESD224 on-chip ESD protection network enables the device to be HDMI 2.0 compliant while providing robust protection to downstream HDMI devices.

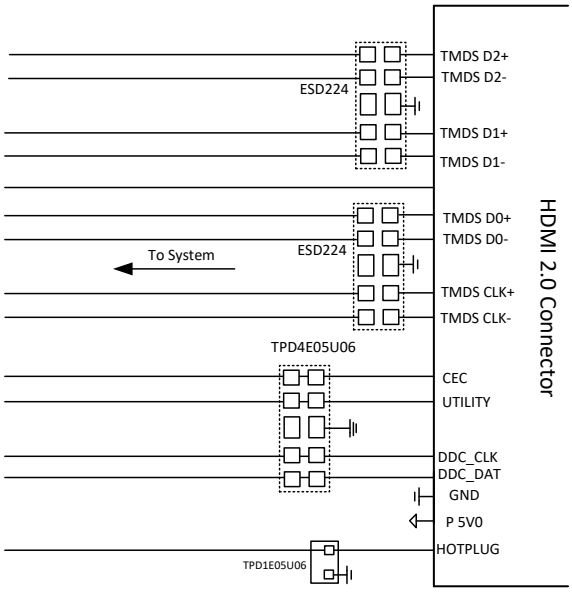
The ESD224 is offered in the industry standard USON-10 (DQA) package. The package features 0.5-mm pin pitch easing implementation and reducing design time.

Device Information(1)

PART NUMBER	PACKAGE	BODY SIZE (NOM)
ESD224	USON (10)	2.50 mm × 1.00 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Typical Application Schematic



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4 Revision History

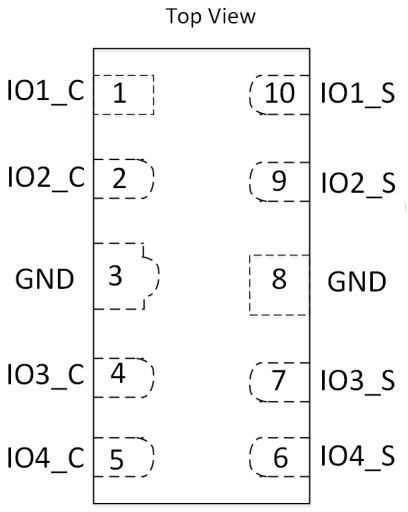
Changes from Original (February 2018) to Revision A **Page**

- Changed product status from Advance Information to Production Data ... 1

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5 Pin Configuration and Functions

DQA Package
10-Pin USON
Top View



USON-10 2.5 mm x 1.0 mm, 0.5 mm pitch

Pin Functions

PIN		TYPE	DESCRIPTION
NAME	NO.		
GND	3	Ground	Ground. Connect to ground. These pins are shorted internally.
GND	8		
IO1_C	1	Connector Side I/O	ESD protected channel to be connected to the connector
IO2_C	2		
IO3_C	4		
IO4_C	5		
IO4_S	6	System Side I/O Pin corresponding to IO4_C	To be connected to the system side
IO3_S	7	System Side I/O Pin corresponding to IO3_C	
IO2_S	9	System Side I/O Pin corresponding to IO2_C	
IO1_S	10	System Side I/O Pin corresponding to IO1_C	

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6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	MAX	UNIT
Electrical Fast Transient	IEC 61000-4-4 Peak Current at 25°C		80	A
Peak Pulse	IEC 61000-4-5 Surge (t_p 8/20 µs) Peak Power at 25°C		17	W
	IEC 61000-4-5 Surge (t_p 8/20 µs) Peak Current at 25°C		2	A
T_A	Operating free-air temperature	-40	125	°C
T_{stg}	Storage temperature	-65	155	°C

(1) Stresses beyond those listed under *Absolute Maximum Rating* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Condition*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings -JEDEC Specifications

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins(1)	±2500	V
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins(2)	±1000	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 ESD Ratings - IEC Specifications

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	IEC 61000-4-2 Contact Discharge, all pins	±12000	V
		IEC 61000-4-2 Air Discharge, all pins	±15000	

6.4 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V_{IN}	Input voltage	-3.6		3.6	V
T_A	Operating Free Air Temperature	-40		125	°C

6.5 Thermal Information

THERMAL METRIC(1)		ESD224 DQA (USON) 10 PINS	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance	173.4	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	109.6	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	77.6	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	14.3	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	77.3	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

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6.6 Electrical Characteristics

At T_A = 25°C unless otherwise noted

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{RWM}	Reverse stand-off voltage	I_{IO} < 10 nA, across operating temperature range	-3.6		3.6	V
V_{BRF}	Breakdown voltage, Pin 1, 2, 4, 5 to 3 (GND) (1)	I_{IO} = 1 mA	5		7.9	V
V_{BRR}	Reverse breakdown voltage, pin 1, 2, 4, 5 to 3 (GND) (1)	I_{IO} = -1 mA	-7.9		-5	V
V_{HOLD}	Holding voltage, pin1, 2, 4, 5 to 3 (GND) and 3 (GND) to pin 1, 2, 4, 5 (2)	I_{IO} = 1 mA		6.3		V
$V_{HOLD-NEG}$	Breakdown voltage, pin1, 2, 4, 5 to 3 (GND) (2)	I_{IO} = -1 mA		-6.3		V
V_{CLAMP}	TLP Clamping voltage (Intrinsic)	IPP = 1 A, pin 1, 2, 4, 5 to 3 or 8(GND), GND to pin 1, 2, 4, 5		7		V
		IPP = 5 A, pin 1, 2, 4, 5 to 3 or 8(GND), GND to pin 1, 2, 4, 5		9		V
		IPP = 16 A, pin 1, 2, 4, 5 to 3 or 8(GND), GND to pin 1, 2, 4, 5		14		V
$V_{CLAMP-IEC-SYS}$	IEC 61000-4-2 30 ns Clamping voltage (system side) assuming system draws at least 3 A of current at 8 V. See measurement setup.	8-kV Contact discharge on pin 1, 2, 4, 5 with pin3 grounded. Voltage waveform measured at pin 6, 7, 9, 10 with respect to GND		8		V
		-8-kV Contact discharge on pin 1, 2, 4, 5 with pin3 grounded. Voltage waveform measured at pin 6, 7, 9, 10 with respect to GND		-5		V
R_{DYN}	Dynamic resistance	Pin 1, 2, 4, 5 to GND, 100 ns TLP		0.5		Ω
		GND to Pin 1, 2, 4, 5 , 100 ns TLP		0.5		Ω
C_{LINE}	Line capacitance, any IO to GND	V_{IO} = 0 V, V_{p-p} = 30 mV, f = 1 MHz		0.5	0.6	pF
ΔC_{LINE}	Variation of line capacitance	C_{LINE1} - C_{LINE2}, V_{IO} = 0 V, Vp-p = 30 mV, f = 1 MHz		0.02	0.07	pF
C_{CROSS}	Line-to-line capacitnace between one differential pair to another differnetial pair	V_{IO} = 0 V, V_{rms} = 30 mV, f = 1 MHz		0.28		pF
S_{21DC}	DC Insertion Loss	DC insertion loss at Ch1, Ch2, Ch3, Ch4		0.3		dB
$I_{leakage}$	Leakage Current	V_{IO}=±3.6 V, Pin 1,2,4,5 to Pin 3		0.1	10	nA

(1) VBRF and VBRR are defined as the voltage obtained at 1 mA when sweeping the voltage up, before the device latches into the snapback state

(2) VHOLD is defined as the voltage when 1 mA is applied, after the device has successfully latched into the snapback state.

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6.7 Typical Characteristics

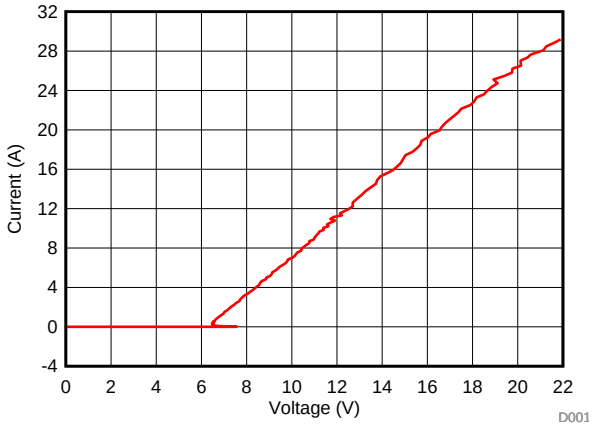


Figure 1. Positive TLP Curve, Connector side IO Pin to GND (t_p=100ns)

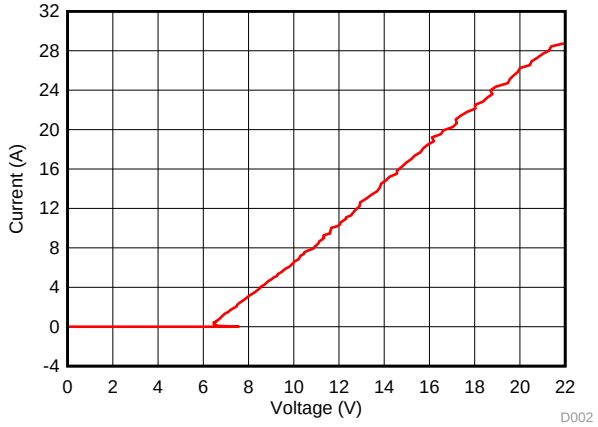


Figure 2. Negative TLP Curve, Connector side IO Pin to GND (Plotted as positive TLP from GND to IO, t_p=100ns)

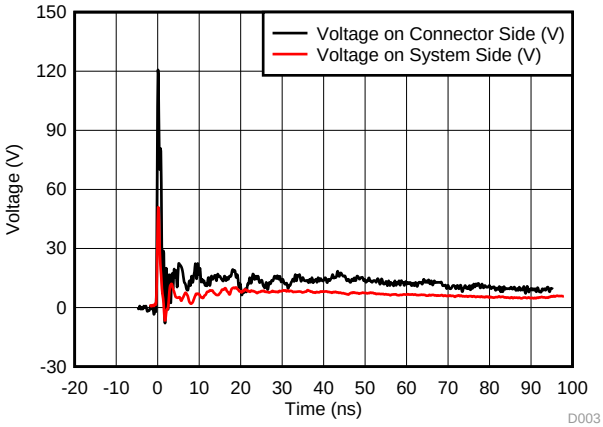


Figure 3. Clamping voltage waveform for +8kV IEC 61000-4-2 stress. See Figure 11 for details.

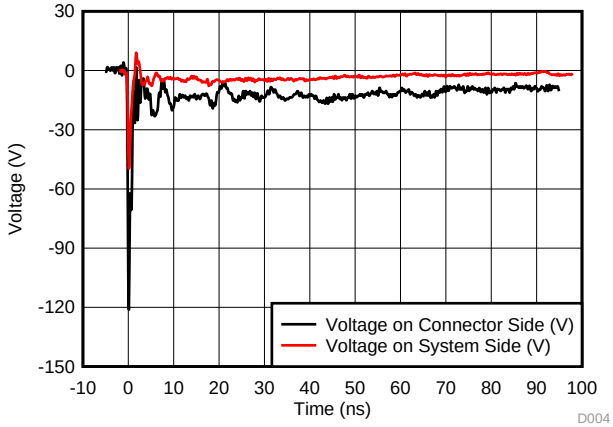


Figure 4. Clamping voltage waveform for -8kV IEC 61000-4-2 stress. See Figure 11 for details.

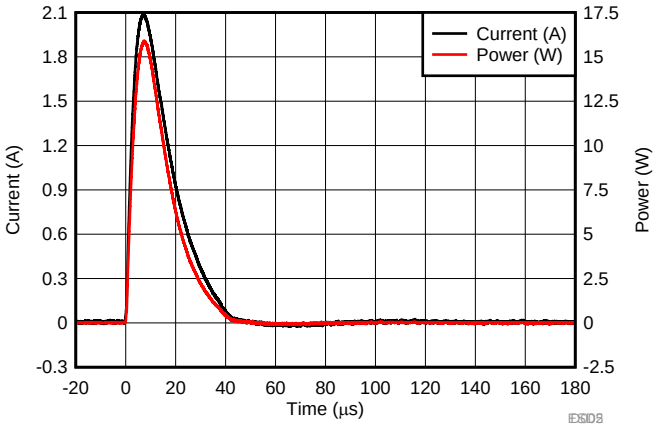


Figure 5. IEC 61000-4-5 Surge Waveform (tp=8/20 µs)

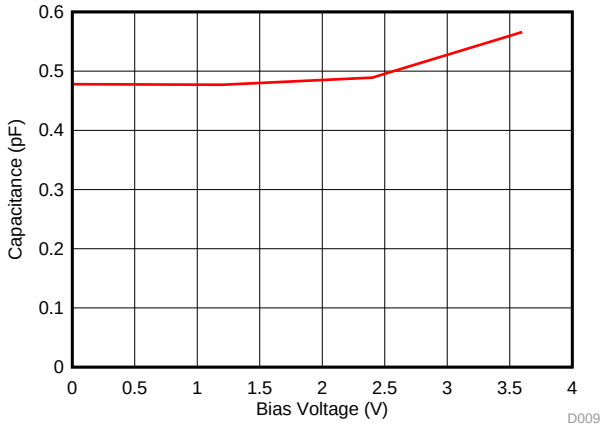


Figure 6. Capacitance vs. Bias Voltage at 25 degree Celsius

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Typical Characteristics (continued)

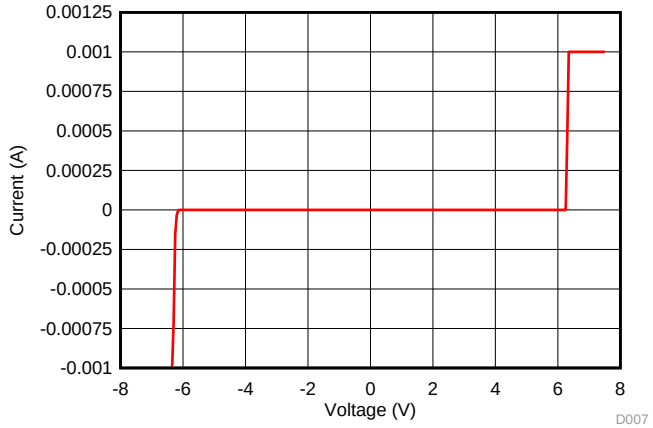


Figure 7. DC Voltage Sweep I-V Curve, IO Pin to GND

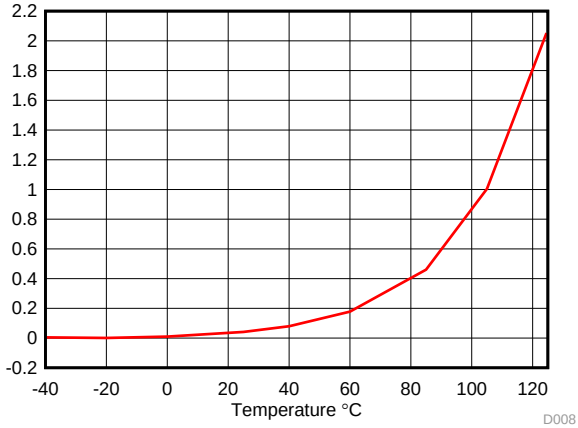


Figure 8. Leakage Current vs Temperature, IO Pin to GND, at 2.5 V Bias

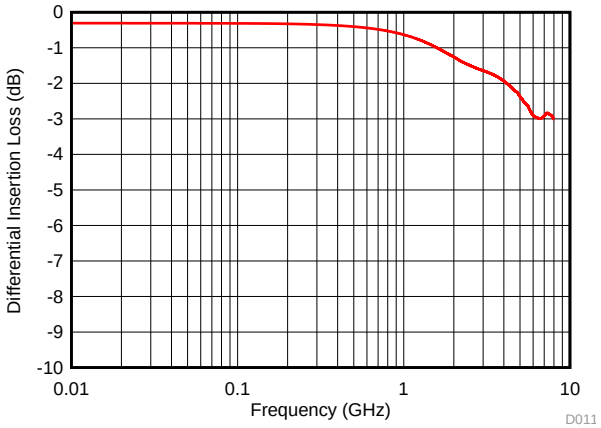


Figure 9. Differential Insertion Loss

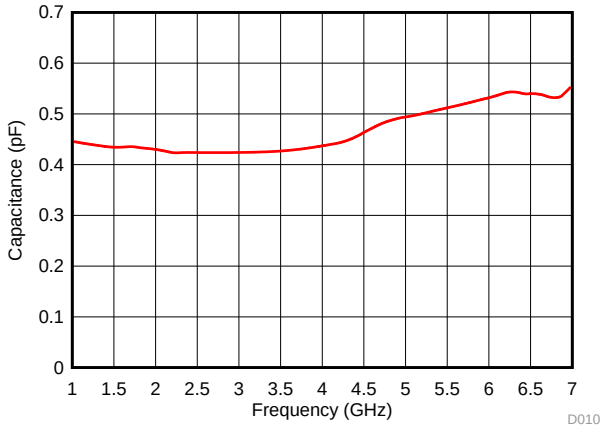


Figure 10. Capacitance vs Frequency

7 Parameter Measurement Setup

7.1 IEC 61000-4-2 System Level ESD Test Setup with HDMI Driver for Clamping Voltage Measurement

Figure 11 shows the setup used to perform System Level ESD test to evaluate the clamping performance of ESD224 in real-world applications where the device is protecting a downstream HDMI driver System-on-Chip. IEC 61000-4-2 8kV Contact stress was applied at the connector pin and the voltage waveform on the system-side pin was captured to look at the clamping voltage presented by ESD224 to the down stream HDMI driver.

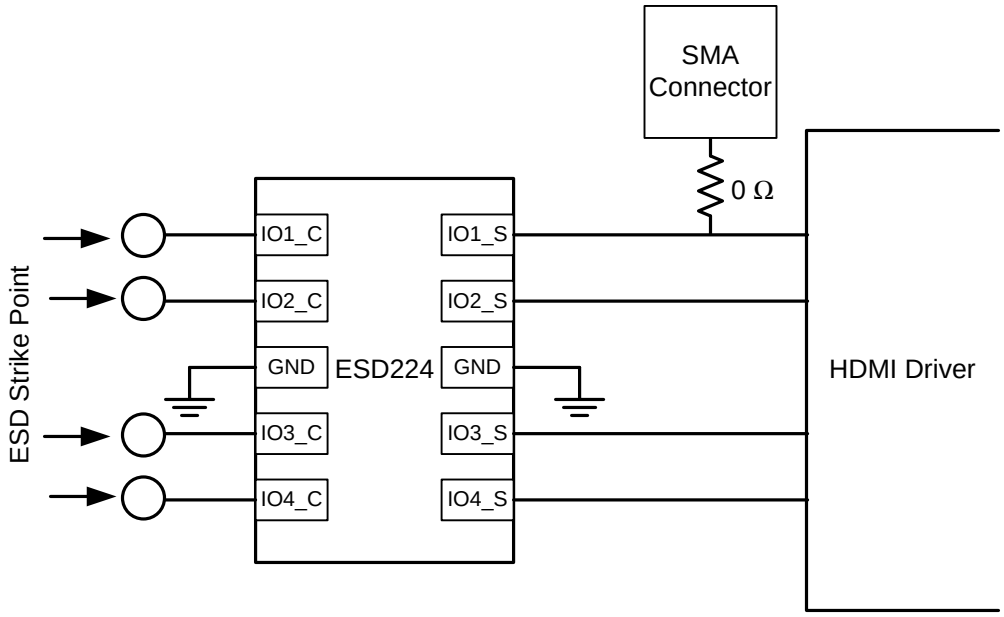


Figure 11. System Level IEC 61000-4-2 ESD Test Setup with ESD224 protecting an HDMI driver chip

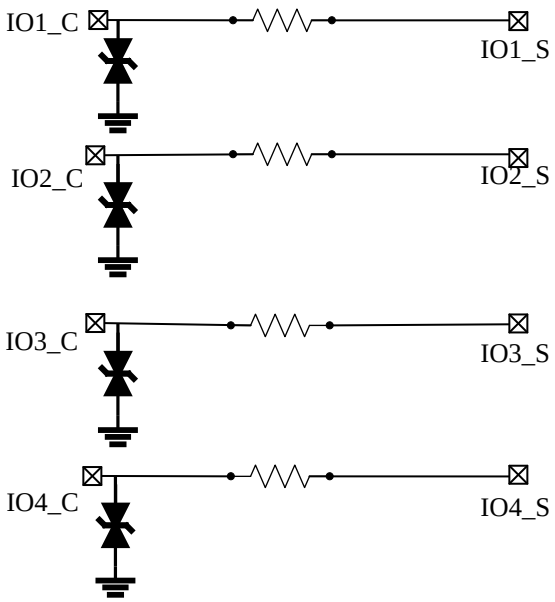
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8 Detailed Description

8.1 Overview

The ESD224 is a bidirectional ESD Protection Diode with ultra-low capacitance. This device can dissipate ESD strikes above the maximum level specified by the IEC 61000-4-2 International Standard. The ultra-low capacitance makes this device ideal for protecting any super high-speed signal pins.

8.2 Functional Block Diagram



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8.3 Feature Description

8.3.1 IEC 61000-4-2 ESD Protection

The I/O pins can withstand ESD events up to ±12-kV contact and ±15-kV air gap. The ESD-surge clamp diverts the current to ground.

8.3.2 IEC 61000-4-4 EFT Protection

The I/O pins can withstand an electrical fast transient burst of up to 80 A (5/50 ns waveform, 4 kV with 50-Ω impedance). The ESD-surge clamp diverts the current to ground.

8.3.3 IEC 61000-4-5 Surge Protection

The I/O pins can withstand surge events up to 2 A and 17 W (8/20 µs waveform). The ESD-surge clamp diverts this current to ground.

8.3.4 IO Capacitance

The capacitance between each I/O pin to ground is 0.5 pF (typical). This device supports data rates up to 6 Gbps.

8.3.5 DC Breakdown Voltage

The DC breakdown voltage of each I/O pin is a minimum of ±5.5 V. This ensures that sensitive equipment is protected from surges above the reverse standoff voltage of ±3.6 V.

Feature Description (continued)

8.3.6 Ultra Low Leakage Current

The I/O pins feature an ultra-low leakage current of 10 nA (maximum) with a bias of ±2.5 V.

8.3.7 Low ESD Clamping Voltage

The I/O pins feature an ESD clamp that is capable of clamping the voltage to 8 V (I_{PP} = 16 A TLP) on the system side pins when the system draws at least 3 A.

8.3.8 Supports High Speed Interfaces

This device is capable of supporting high speed interfaces up to 6 Gbps, because of the extremely low IO capacitance.

8.3.9 Industrial Temperature Range

This device features an industrial operating range of –40°C to +125°C.

8.4 Device Functional Modes

The ESD224 is a passive integrated circuit that triggers when voltages are above V_{BRF} or below V_{BRR}. During ESD events, voltages as high as ±15 kV (air) can be directed to ground via the internal diode network. When the voltages on the protected line fall below the trigger levels of ESD224 (usually within 100s of nano-seconds) the device reverts to passive.

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9 Application and Implementation

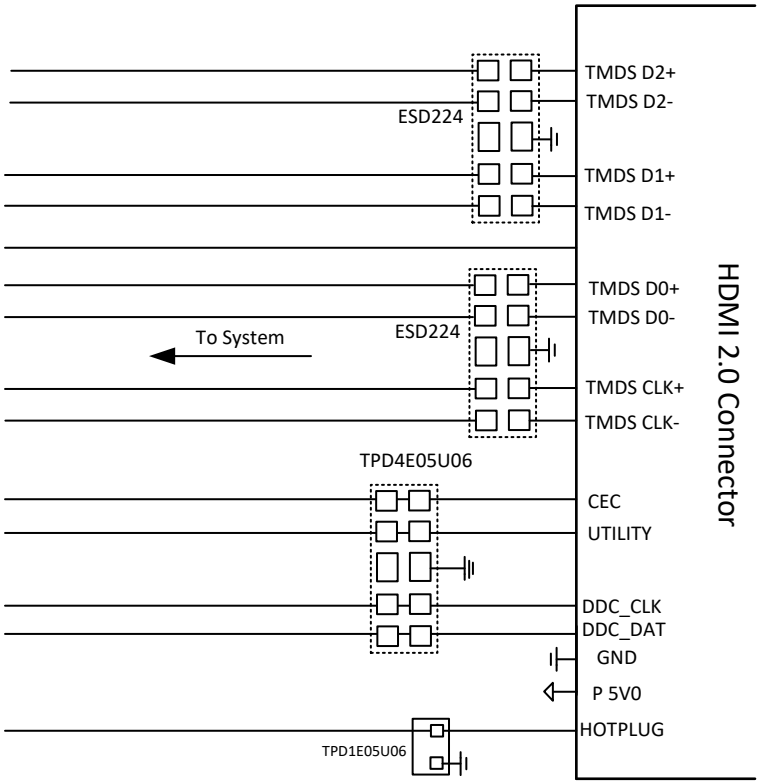
NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The ESD224 is a diode type TVS which is used to provide a path to ground for dissipating ESD events on high-speed signal lines between a human interface connector and a system. As the current from ESD passes through the TVS, only a small voltage drop is present across the diode. Part of this voltage drop across the diode drops across the series element between the connector side pin and the system-side pin. Therefore, the effective voltage drop across the protected IC is smaller than the voltage drop across the diode. It is recommended to avoid through-routing for this ESD diode (single trace connecting both the connector side pin and the system side pin) for the best ESD performance.

9.2 Typical Application



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Figure 12. ESD224 Protecting the HDMI Interface

Typical Application (continued)

9.2.1 Design Requirements

In this design example, two ESD224 devices, one TPD4E05U06 and one TPD1E05U06 device are used to protect an HDMI 2.0 interface. For HDMI 2.0 application design parameters listed in Table 1 are known.

Table 1. Design Parameters

DESIGN PARAMETER	VALUE
Signal range on high speed differential data lines	0 to 3.6 V
Operating frequency of high speed data lines	3 GHz (First Harmonic)
Signal range on control lines (CEC, UTILITY, DDC_CLK and DDC_DAT)	0 to 5 V

9.2.2 Detailed Design Procedure

9.2.2.1 Signal Range

ESD224 supports signal ranges between –3.6 V and 3.6 V, which supports the high-speed lines on the HDMI 2.0 application. The TPD4E05U06 and TPD1E05U06 support signal ranges between 0 V and 5.5 V, which supports the HDMI control lines.

9.2.2.2 Operating Frequency

The ESD224 has a 0.5 pF (typical) capacitance, which supports the HDMI 2.0 rate of 6 Gbps. The TPD4E05U06 and TPD1E05U06 have a typical capacitance of 0.5 pF and 0.42 pF respectively, which easily support the control lines. The ESD224 has 4 identical protection channels for the differential HDMI high-speed signal lines. The symmetrical pin out of the device with a ground pin between the two differential signal pins makes it suitable for this application.

9.2.3 Application Curves

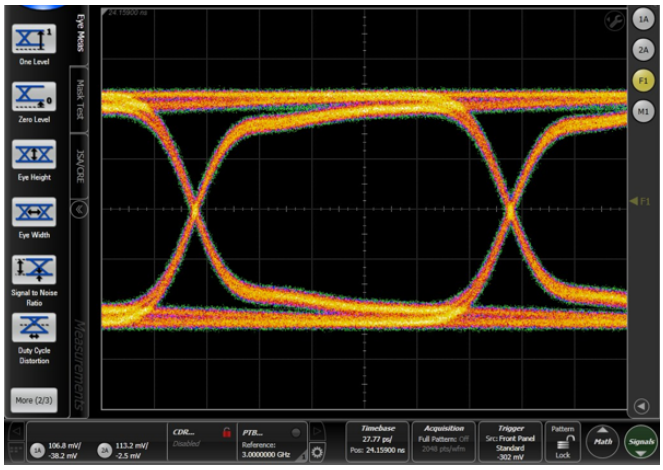


Figure 13. HDMI 2.0 6 Gbps Eye Diagram (Bare Board)

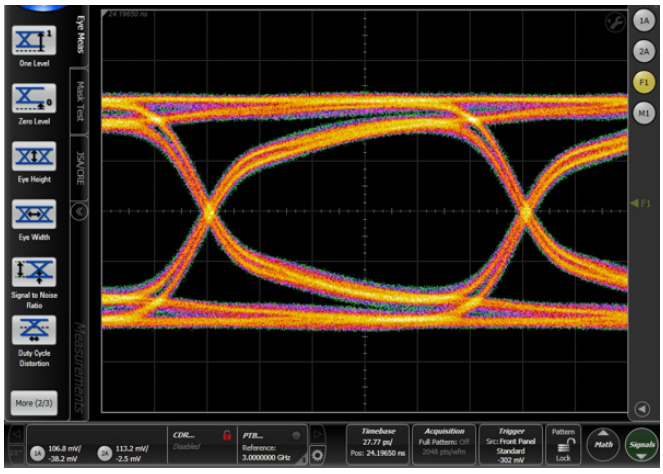


Figure 14. HDMI 2.0 6 Gbps Eye Diagram with ESD224

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10 Power Supply Recommendations

This device is a passive ESD device so there is no need to power it. Take care not to violate the recommended I/O specification (–3.6 V to 3.6 V) to ensure the device functions properly.

11 Layout

11.1 Layout Guidelines

- The optimum placement is as close to the connector as possible.
  - EMI during an ESD event can couple from the trace being struck to other nearby unprotected traces, resulting in early system failures.
  - The PCB designer must minimize the possibility of EMI coupling by keeping any unprotected traces away from the protected traces which are between the TVS and the connector.
- For the best ESD performance, do not use through-routing for the data channels. Connecting pins 1 and 10, 2 and 9, 4 and 7, 5 and 6 together with through routing will reduce the clamping voltage performance of ESD224.
- Route the protected traces as straight as possible.
- Eliminate any sharp corners on the protected traces between the TVS and the connector by using rounded corners with the largest radii possible.
  - Electric fields tend to build up on corners, increasing EMI coupling.

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11.2 Layout Examples

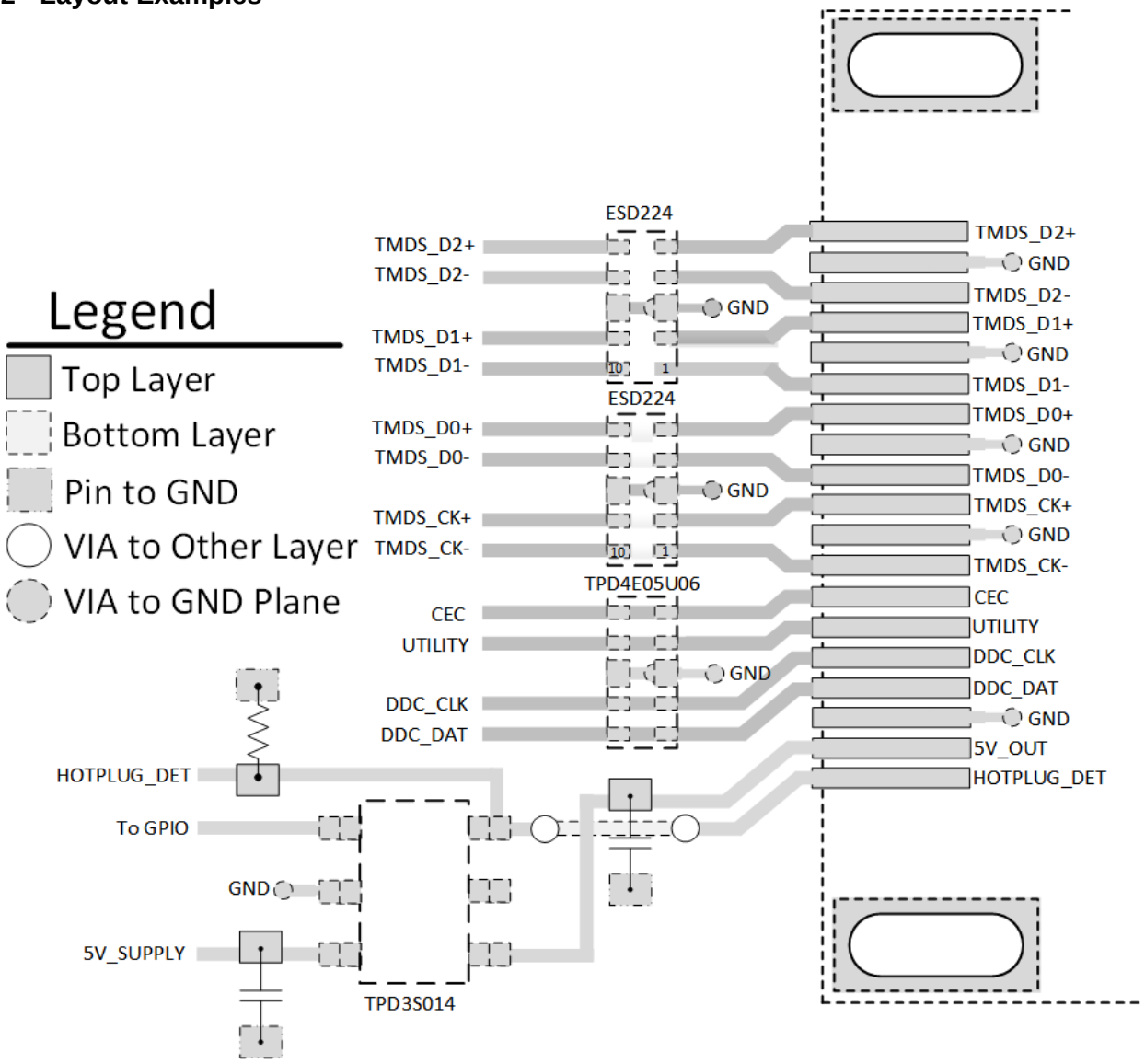


Figure 15. HDMI Type-A Transmitter Port Layout

NOTE

There is no Through-Routing for the ESD224 Pins Connecting to the High Speed Data Lines.

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12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

For related documentation see the following:

12.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community ***TI's Engineer-to-Engineer (E2E) Community.*** Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support ***TI's Design Support*** Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.4 Trademarks

E2E is a trademark of Texas Instruments.

12.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.6 Glossary

SLYZ022 — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
ESD224DQAR	Active	Production	USON (DQA) | 10	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	1AR
ESD224DQAR.B	Active	Production	USON (DQA) | 10	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	1AR

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

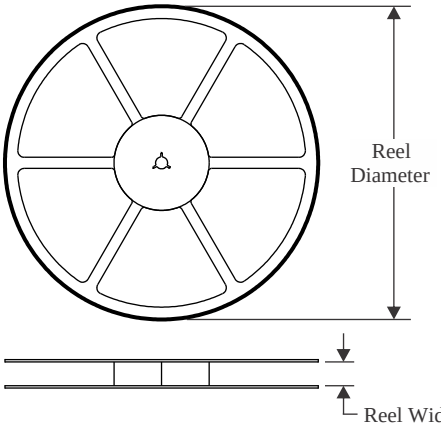
Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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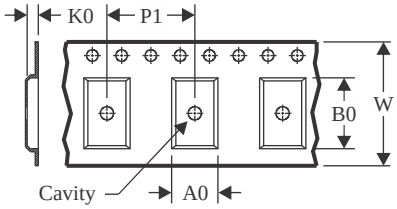
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION

REEL DIMENSIONS

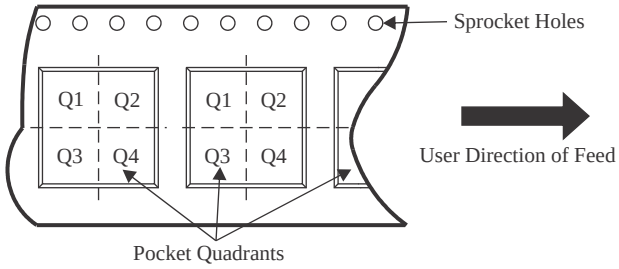


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

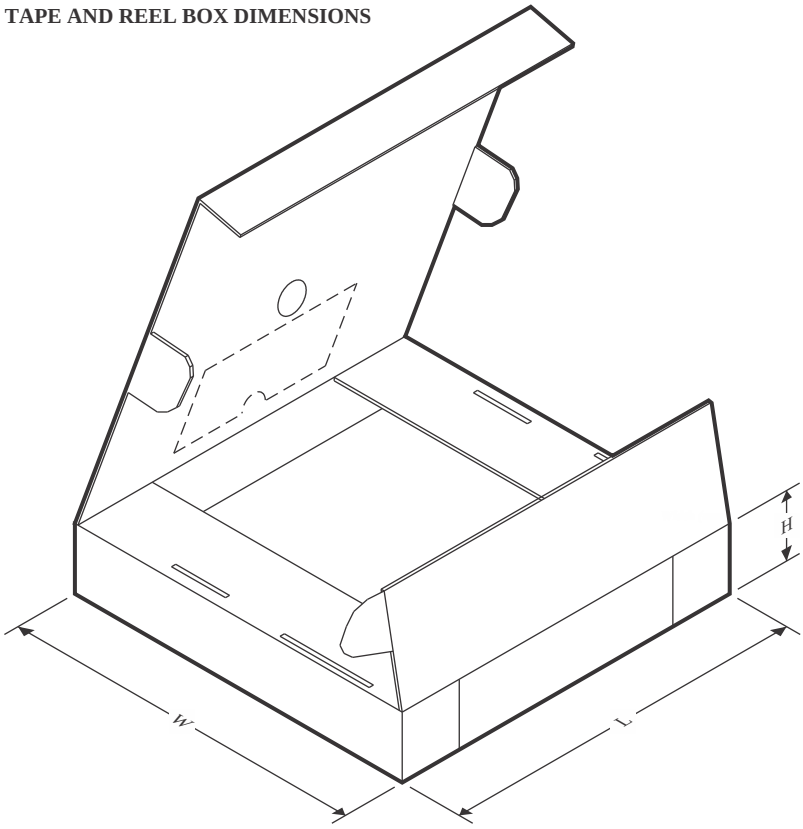
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ESD224DQAR	USON	DQA	10	3000	180.0	8.4	1.2	2.7	0.63	4.0	8.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ESD224DQAR	USON	DQA	10	3000	210.0	185.0	35.0

GENERIC PACKAGE VIEW

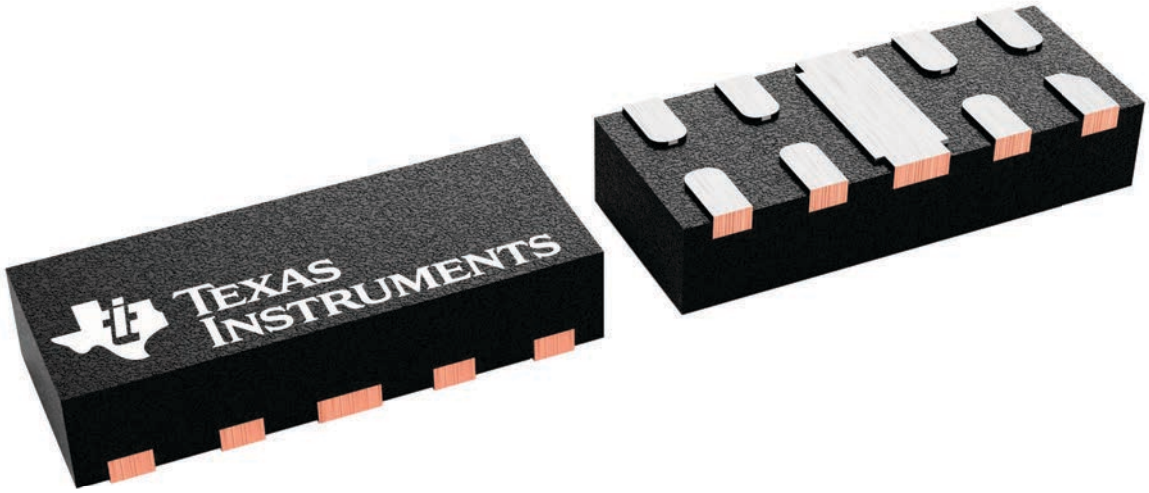
DQA 10

USON - 0.55 mm max height

1 x 2.5, 0.5 mm pitch

PLASTIC SMALL OUTLINE - NO LEAD

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



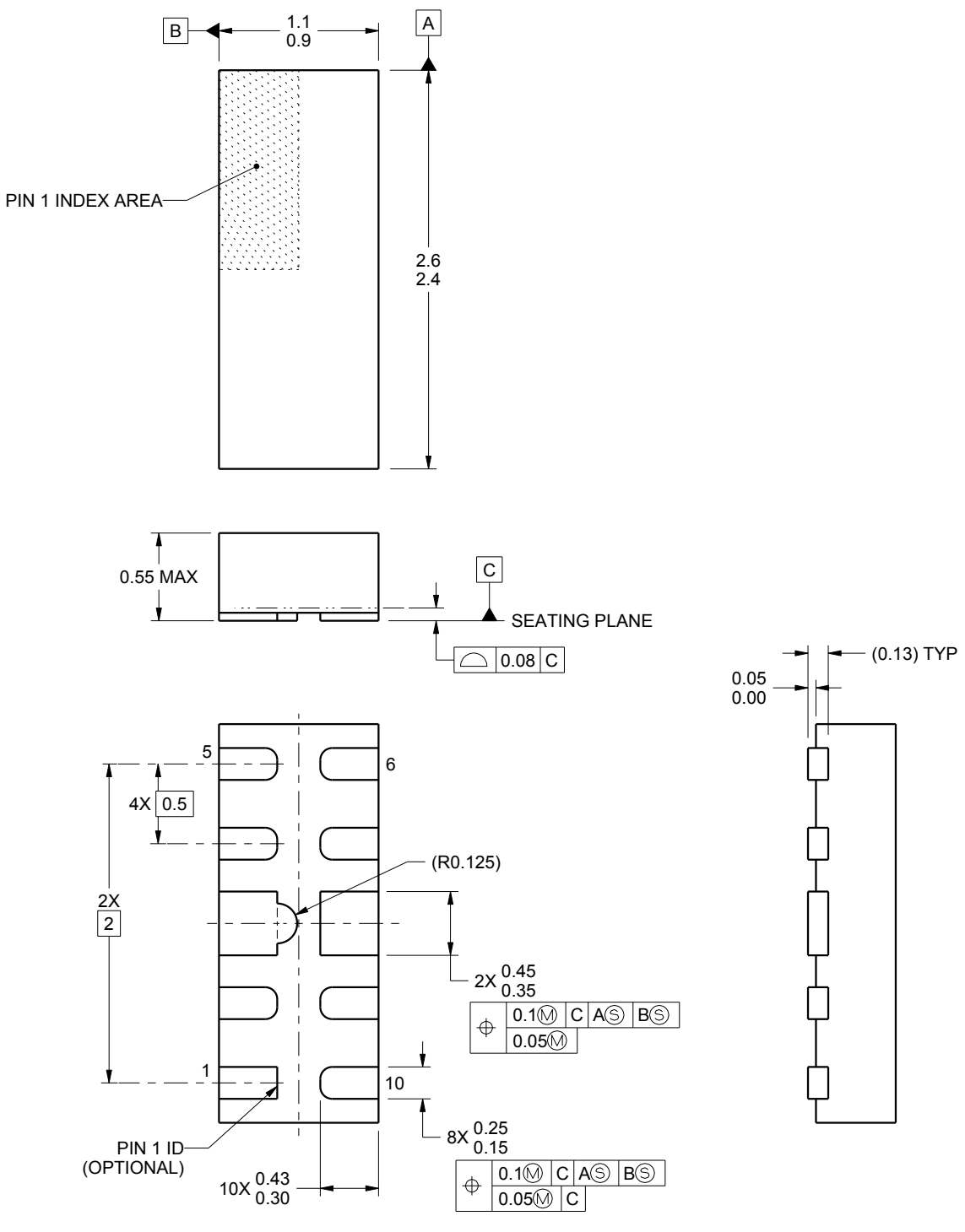
4230320/A

PACKAGE OUTLINE

DQA0010A

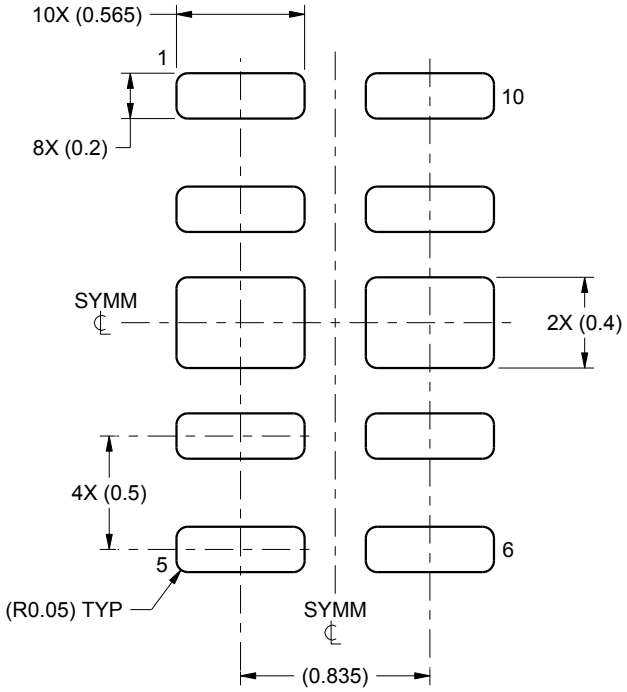
USON - 0.55 mm max height

PLASTIC SMALL OUTLINE - NO LEAD

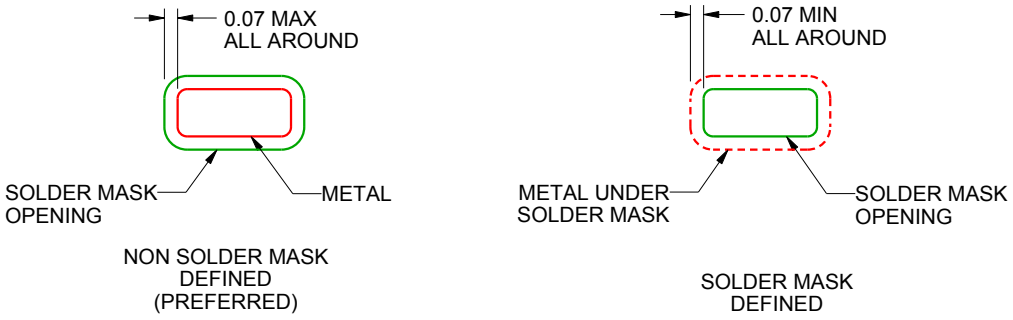


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.



LAND PATTERN EXAMPLE
SCALE:30X



SOLDER MASK DETAILS

4220328/A 12/2015

NOTES: (continued)

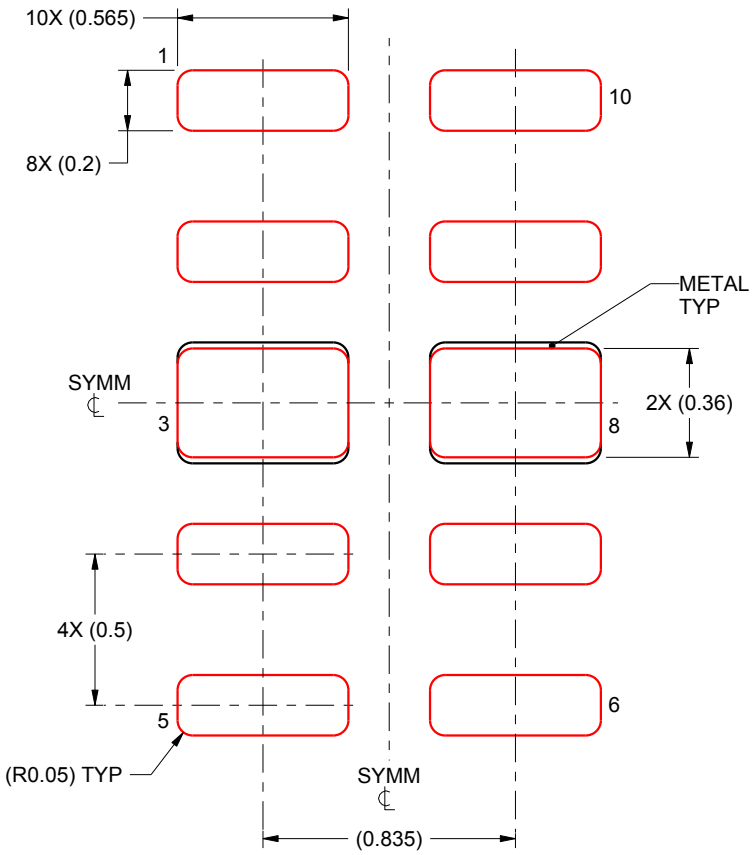
3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

EXAMPLE STENCIL DESIGN

DQA0010A

USON - 0.55 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.1 mm THICK STENCIL

EXPOSED PADS 3 & 8:
90% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE
SCALE:40X

4220328/A 12/2015

NOTES: (continued)

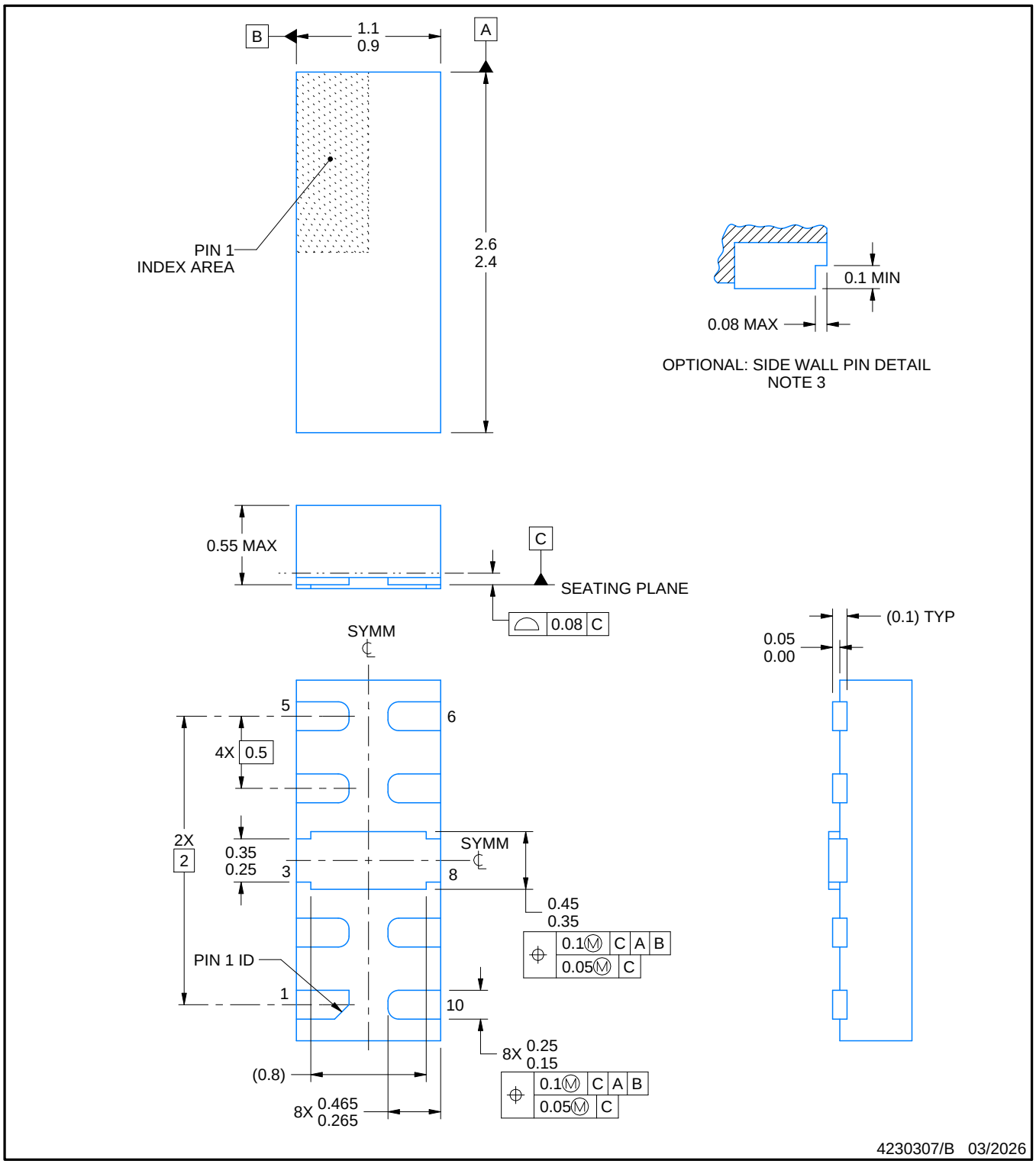
4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

PACKAGE OUTLINE

DQA0010B

USON - 0.55 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES:

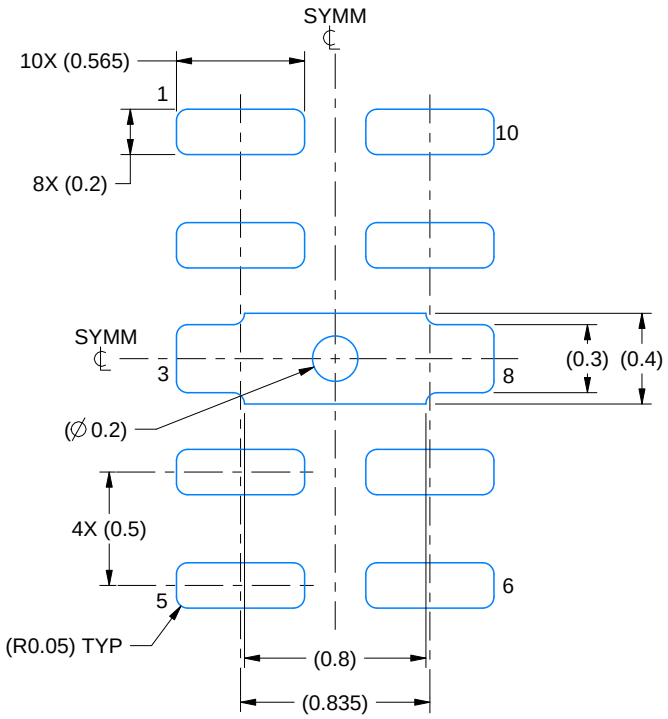
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Minimum 0.1 mm solder wetting on pin side wall. Available for wettable flank version only.

EXAMPLE BOARD LAYOUT

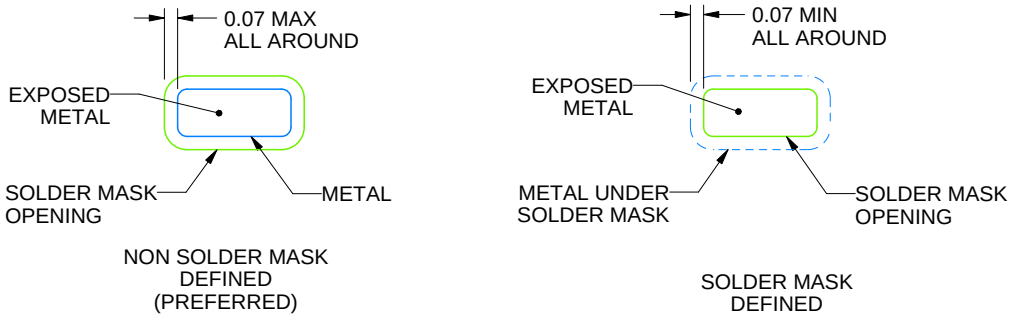
DQA0010B

USON - 0.55 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:30X

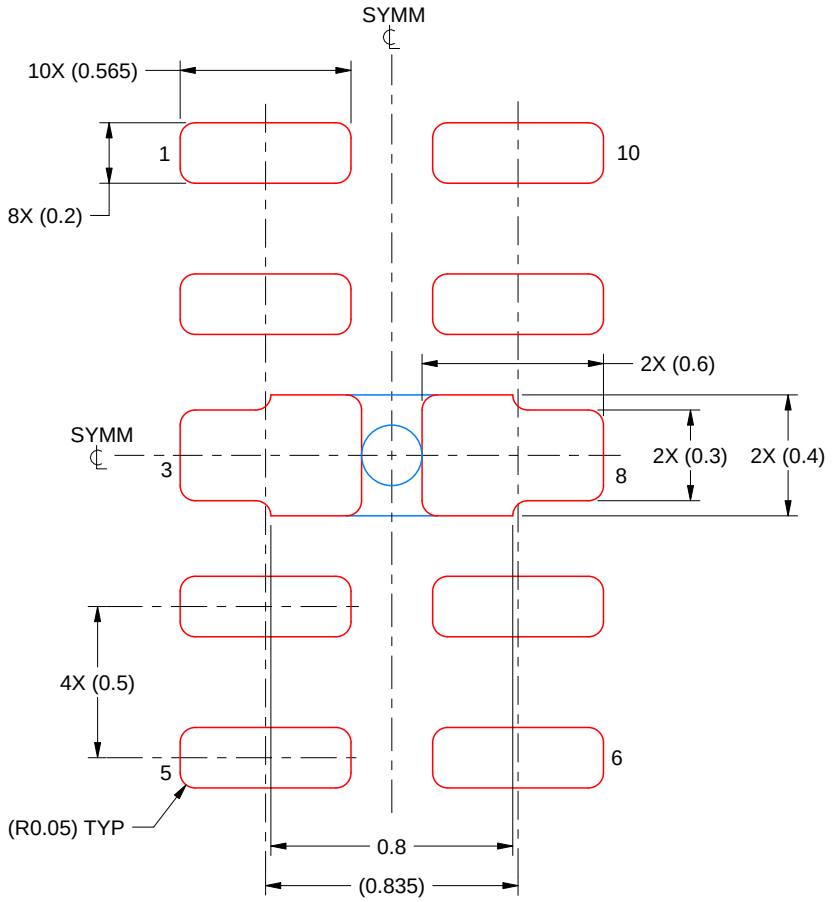


SOLDER MASK DETAILS

4230307/B 03/2026

NOTES: (continued)

4. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).



SOLDER PASTE EXAMPLE
BASED ON 0.1 mm THICK STENCIL
SCALE:40X

4230307/B 03/2026

NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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